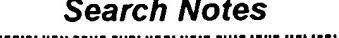


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/611,692	JACOBS ET AL.
	Examiner Jason M. Han	Art Unit 2875

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner